

Notice of References CitedApplication/Control No.
09/579,532Applicant(s)/Patent Under
Reexamination
FUKUDA ET AL.Examiner
Michael W. HoyerArt Unit
2614

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,421,069 B1	07-2002	Ludtke et al.	345/762
	B	US-5,648,824	07-1997	Dunn et al.	725/37
	C	US-6,314,326 B1	11-2001	Fuchu, Katsuki	700/17
	D	US-6,288,716 B1	09-2001	Humpleman et al.	345/733
	E	US-5,883,621	03-1999	Iwamura, Ryuichi	725/131
	F	US-6,453,110 B1	09-2002	Kawamura et al.	386/46
	G	US-6,593,937 B2	07-2003	Ludtke et al.	348/563
	H	US-6,496,860 B2	12-2002	Ludtke et al.	709/223
	I	US-5,793,366	08-1998	Mano et al.	345/839
	J	US-6,400,280 B1	06-2002	Osakabe, Yoshio	348/734
	K	US-6,211,800 B1	04-2001	Yanagihara et al.	341/50
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.